

TEST REPORT EN 60947-6-1

Low-voltage switchgear and controlgear Part 6-1: Multiple function equipment – Transfer switching equipment

Report Number.....: (2019)FQIIDQCE-0184-H1

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Name of Testing Laboratory Fujian Inspection and Research Institute for Product Quality (FQII)

preparing the Report....:

Applicant's name: Zhejiang Tengen Electrics Co.,Ltd.

Address......: Sulv Industry Area, Liushi Town, Yueqing City, Zhejiang

Province, P.R.China

Test specification:

Standard: EN 60947-6-1:2005 + A1:2014

Test procedure: /
Non-standard test method: N/A

Test Report Form No.....: IEC60947_6_1C

Test Report Form(s) Originator: SGS Fimko Ltd

Master TRF: Dated 2019-07-02

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Test item description::	ATSE		
Trade Mark::	TENGEN		
Manufacturer:	Zhejiang Tengen Electrics Co.,Ltd. Sulv Industry Area, Liushi Town, Yueqing City, Zhejiang Province, P.R.China		
Model/Type reference:	TGQ1N-160L/3,TGQ1N-160M/3,TGQ1N-160L/4,TGQ1N-160M/4		
Ratings:	Uimp:8kV(main circuit),2.5kV(control circuit); Ui:800V(main circuit),400V(control circuit); Ue:AC400V; Ith:100A; Ie:100A,125A,140A,160A; Utilization category:AC-33B; Icm:73.5kA(Type L),105kA(Type M); Icn:35kA(Type L),50kA(Type M); Class CB;Method of controlling: ATSE,RTSE; 3P, 4P.		

Responsible Testing Laboratory (as applicable), testing procedure and testing location(s):				
	CB Testing Laboratory:	Fujian Inspection and Research Institute for Product Quality (FQII)		
Testing location/ address:		No. 121, Shan Tou Jiao, West Yang Qiao Road, Fuzhou,Fujian 350002 China& No.101 Baozhen Road Mawei Economic Development Zone Fuzhou, Fujian, China		
Tested by (name, function, signature):		Zhang Xuejun (Engineer)	3.45章	
Арр	roved by (name, function, signature):	Wei Yunming (Chief Engineer)	(ching	
	Testing procedure: CTF Stage 1:			
Test	ing location/ address:			
Tested by (name, function, signature):				
Approved by (name, function, signature):				
	Testing procedure: CTF Stage 2:			
Testing location/ address:				
Tested by (name, function, signature):				
Witnessed by (name, function, signature) .:				
Approved by (name, function, signature):				
	Testing procedure: CTF Stage 3 or 4:			
Testing location/ address:				
Tested by (name, function, signature):				
Witnessed by (name, function, signature) .:				
Approved by (name, function, signature):				
Supervised by (name, function, signature) :				